



PRECISION COMPOSITE OPTICAL ELEMENTS

**PAUL B. WILLIS
JET PROPULSION LABORATORY
CALIFORNIA INSTITUTE OF TECHNOLOGY
4800 Oak Grove Drive, Pasadena, CA 91109
(818) 354-6998 paul.b.willis@jpl.nasa.gov**

MLS MISSION

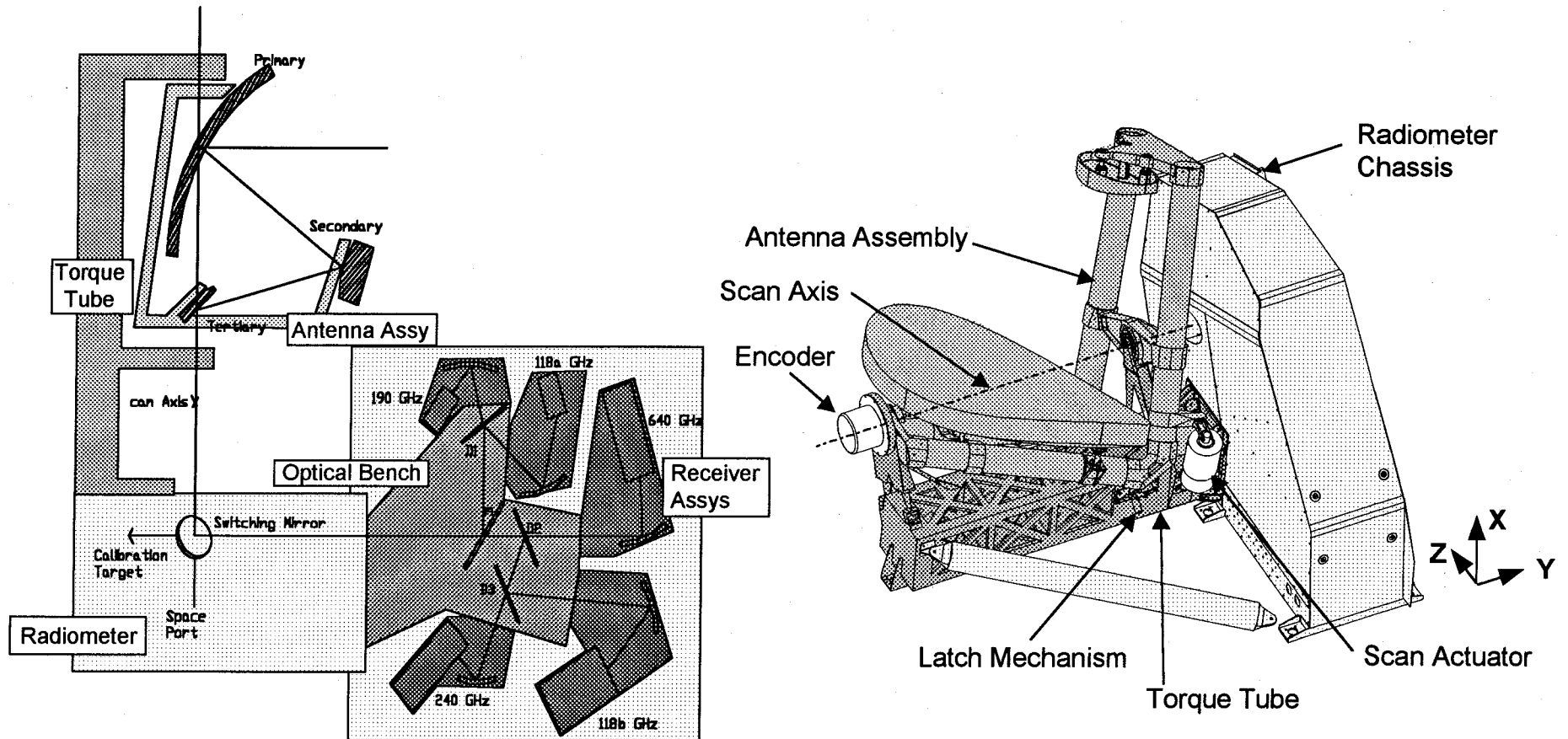
(MICROWAVE LIMB SOUNDER)

- **SATELLITE:**
FUNDED BY GODDARD; PART OF THE EARTH OBSERVING SYSTEMS (EOS) “CHEM” PLATFORM, BUILT BY TRW, FOR LAUNCH IN 2002. SUCCESSOR TO THE UPPER ATMOSPHERE RESEARCH SATELLITE (UARS)
- **SCIENCE GOALS:**
ACQUIRE AND ANALYZE MICROWAVE SIGNALS FROM EARTH’S ATMOSPHERE. DETERMINE: (a) IS THE OZONE HOLE RECOVERING, (b) HOW DO KEY GASES MIX, AND, (c) DETECT CHANGES IN OVERALL CLIMATE OF THE EARTH
- **MEASUREMENTS:**
MICROWAVES EMITTED BY WATER VAPOR, OZONE, CHLORINE OXIDES, NITROGEN OXIDES AND OTHER KEY GASES

MLS INSTRUMENT

- **MODULES:
GIGAHERTZ, TERAHERTZ (WATER), & SPECTROMETER**
- **GIGAHERTZ MODULE:
CONSISTS OF ANTENNA AND RADIOMETER. THE
ANTENNA IS A THREE REFLECTOR CLEAR-APERTURE
OFFSET CASSEGRAIN SYSTEM THAT COLLECTS AND
FOCUSES MICROWAVE RADIATION INTO THE
RADIOMETER FOR ANALYSIS**
- **RADIOMETER: DIRECTS THE SIGNALS TO DETECTORS
CENTERED AT 118, 190, 240 AND 640 GHz; GENERATES
INTERMEDIATE FREQUENCIES, AMPLIFY, DOWN-
CONVERT, ANALYZE, SEND TO TELEMETRY**
- **SHORTEST WAVELENGTH (640 GHz) IS 470 MICRONS**

MLS INSTRUMENT



January 25, 2001

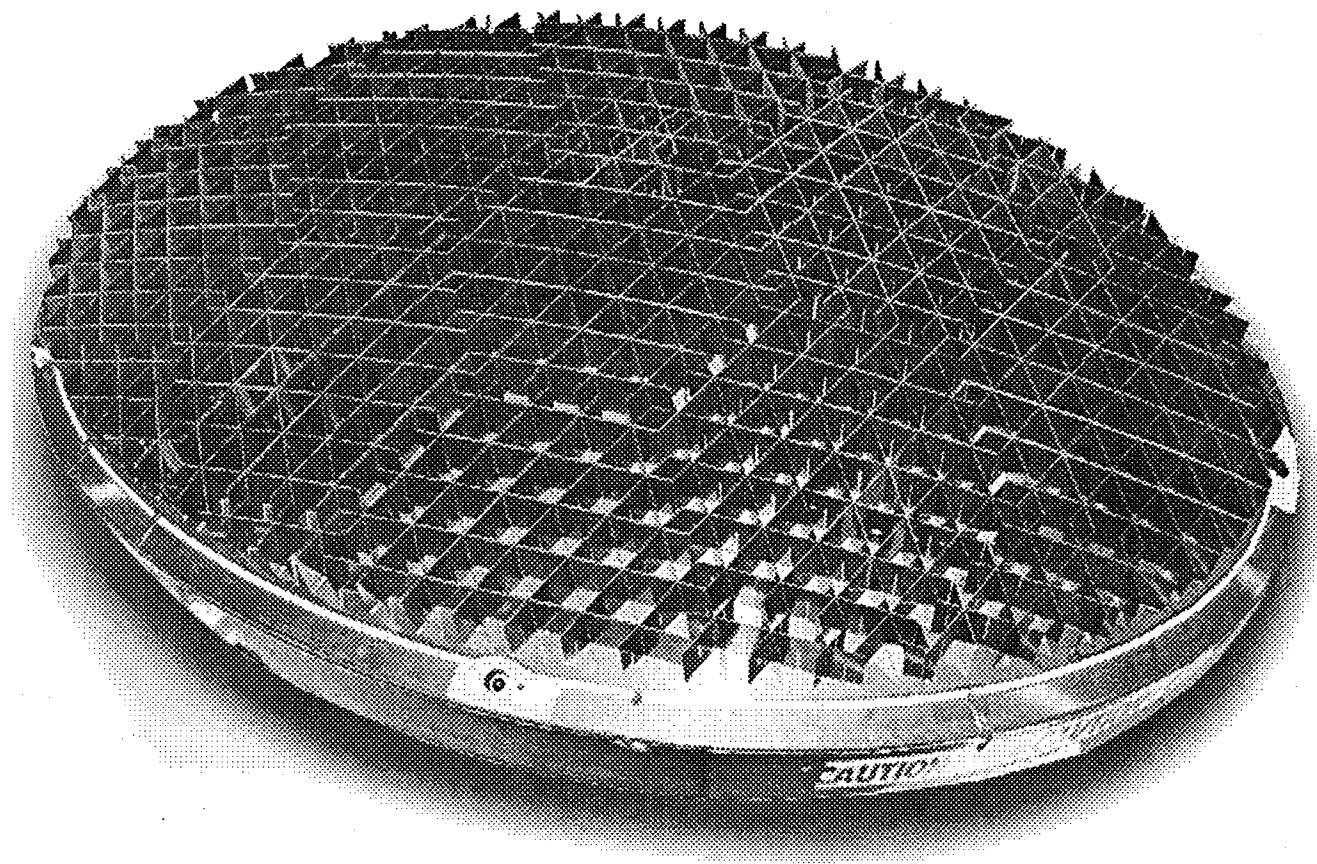
SAMPE



MLS PRIMARY REFLECTOR REQUIREMENTS

- **PRIMARY REFLECTOR IS THE HEART OF THE MICROWAVE COLLECTION SYSTEM**
- **DIMENSIONS: ELIPTICAL, 1.6 x 0.8 METERS**
- **SURFACE AREA: 1.005 SQUARE METERS**
- **MASS LIMIT: 10 Kg (Maximum)**
- **CONSTRUCTION: COMPOSITE FACESHEETS (REPRODUCED OFF CARBON MOLD) WITH ADHESIVELY BONDED COMPOSITE RIB STRUCTURE (COMPOSITE OPTICS, INC.)**
- **MATERIAL: COMPOSITE - HIGH MODULUS GRAPHITE FIBER (M55J) WITH CYANATE ESTER RESIN (954-3), 350°F CURE**
- **FIGURE ACCURACY REQUIRED: 8.5 MICRONS, RMS (LAMBDA OVER FIFTY)**

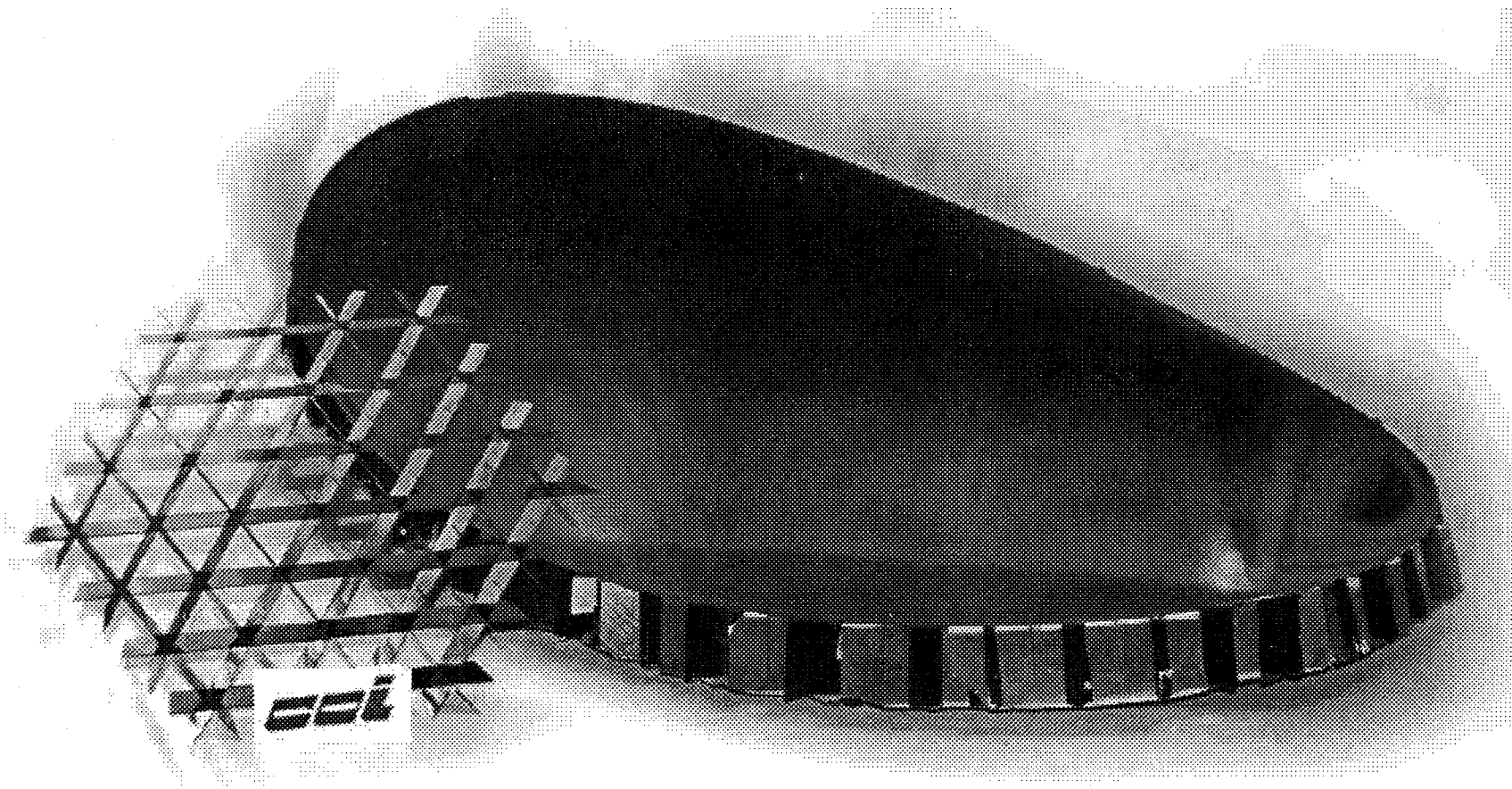
MLS PRIMARY REFLECTOR MOLD AND CORE ASSEMBLY



January 25, 2001

SAMPE

MLS PRIMARY REFLECTOR



January 25, 2001

SAMPE

MLS PRIMARY REFLECTOR REQUIREMENTS

- **RF PERFORMANCE: REFLECTIVE FROM 118 TO 640 GHz, REQUIRES COATING WITH 1.2 MICRONS OF VAPOR DEPOSITED ALUMINUM (“VDA”, FIVE SKIN DEPTHS) (SURFACE OPTICS CORP.)**
- **SPECULARITY: SOLAR, <10% AT 10° ANGLE OF CONE, TO PREVENT THERMAL LOADING OF SECONDARY AND OTHER REFLECTORS. ACCOMPLISHED BY PRECISION GRIT BLASTING OF THE SURFACE UNDER CNC CONTROL**
- **THERMAL BALANCE REQUIREMENTS:**
ABSORPTANCE = < 0.40
ABSORPTANCE/EMITTANCE $1.0 < \alpha / \epsilon < 2.0$
- **EMISSION: ACHIEVED BY DEPOSITING AN 0.8 MICRON LAYER OF REACTIVELY FORMED SILICON SUBOXIDE (SiO_x) (SURFACE OPTICS CORP.)**



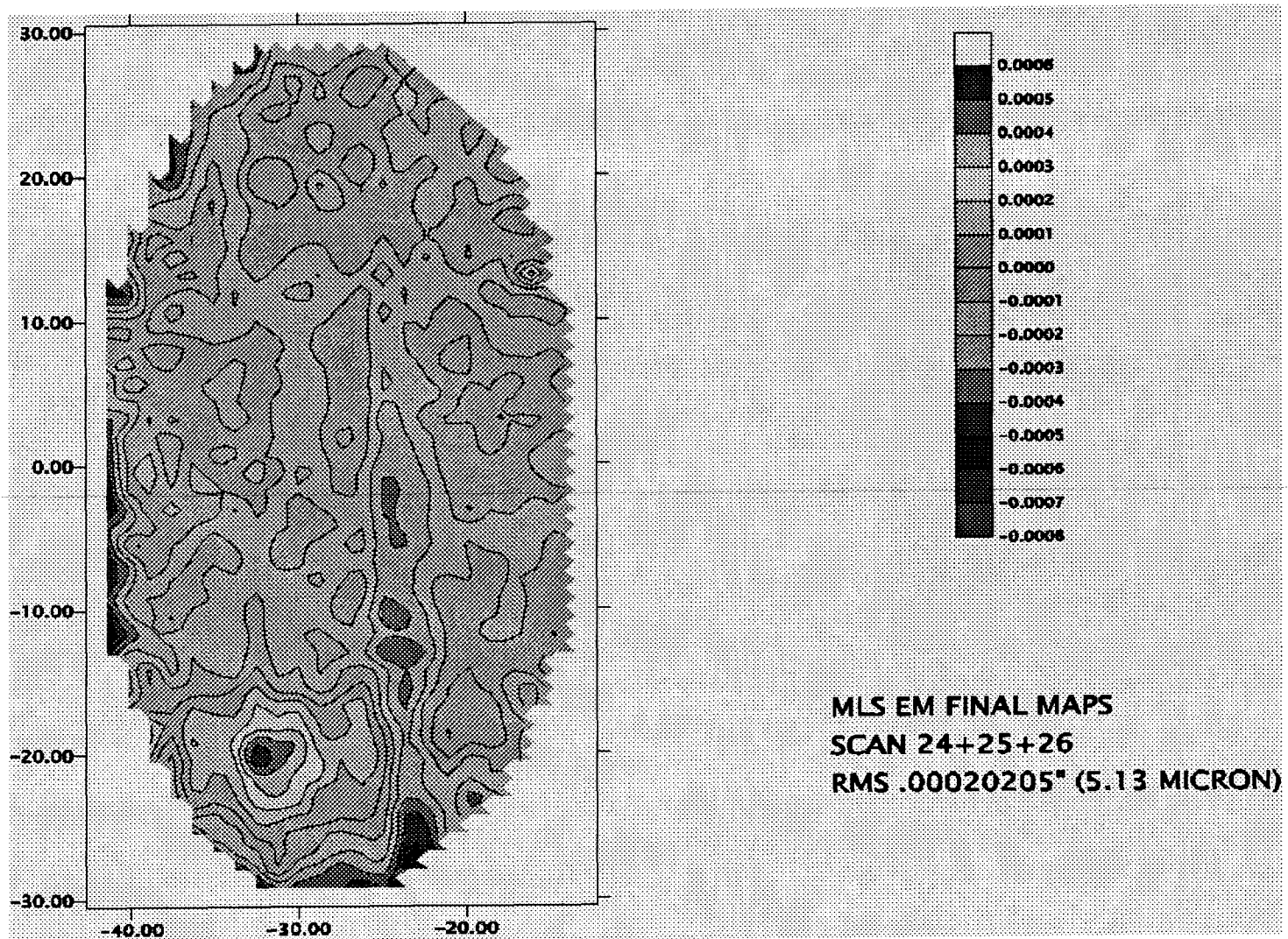
MLS PRIMARY REFLECTOR FIGURE MEASUREMENTS

- **COORDINATE MEASUREMENT MACHINE: BROWN & SHARP - VALIDATOR 7236, PC-DMIS SOFTWARE, NEW ROTARY ENCODERS, OPERATED BY COMPOSITE OPTICS, INC.**
- **STATISTICAL ACCURACY: ESTIMATED AT 2.5 MICRONS OVER ENTIRE REFLECTOR AREA**
- **NUMBER OF POINTS: 1270**
- **NUMBER OF SCANS: THREE PER MEASUREMENT**
- **FINAL FIGURE: ROOT-SUM-SQUARE OF THE THREE RMS VALUES**



MLS PRIMARY REFLECTOR

TYPICAL CMM FIGURE MEASUREMENT



January 25, 2001

SAMPE

10



MLS PRIMARY REFLECTOR FIGURE MEASUREMENTS

- **FIGURE MEASUREMENT SUMMARY:**

AS FABRICATED	4.50 MICRONS, RMS
AFTER THERMAL CYCLING (10 Cycles, -85°C to +90°C)	4.39 MICRONS, RMS
THERMAL VACUUM/ACOUSTIC (72 Hrs/+90°C, 143 dB 30 Hz to 10 KHz)	4.45 MICRONS, RMS
FOLLOWING GRIT BLASTING	4.52 MICRONS, RMS
FOLLOWING VDA COATING	4.37 MICRONS, RMS
- **PRIMARY REFLECTOR FIGURE APPEARS TO BE STABLE TO ALL PROCESSING CONDITIONS WITHIN THE ACCURACY OF THE CMM MACHINE**
- **MAJOR ERROR FEATURES ALSO MAP TO MOLD SURFACE. MOLD APPEARS TO BE THE LARGEST SOURCE OF ERROR**

MLS PRIMARY REFLECTOR PERFORMANCE SUMMARY

- | <u>PROPERTY</u> | <u>REQUIREMENT</u> | <u>ACTUAL</u> |
|---|---|------------------------------|
| MASS | 10 Kg | 8.6 Kg |
| AREAL DENSITY | < 10 Kg/m² | 8.5 Kg/ m² |
| STIFFNESS | 80 Hz | 288 Hz |
| FIGURE | 8.5 Microns, rms | 4.37 Microns, rms |
| ABSORPTANCE | =< 0.40 | 0.43 |
| α / ϵ RATIO | $1.0 < \alpha / \epsilon < 2.0$ | 1.30 |
| SPECULARITY | <10% (10°angle) | 7% (10°angle) |
- CONCLUSIONS: VERY LARGE, HIGHLY ACCURATE AND LOW MASS REFLECTORS CAN BE FABRICATED USING COMPOSITES TECHNOLOGY**

COMPOSITE REFLECTORS FUTURE TRENDS

- **FIGURE OF MERIT:
APERTURE (m²) / MASS (Kg) * FIGURE(μ rms) = TWICE THE
VALUE OF THE NEW 8.1 m GEMINI REFLECTOR (HAWAII)**
- **FIGURE ACCURACY:
ONE ORDER OF MAGNITUDE IMPROVEMENT REQUIRED
FOR INFRARED PERFORMANCE (λ /10); TWO ORDERS OF
MAGNITUDE IMPROVEMENT REQUIRED FOR VISIBLE**
- **ERROR CORRECTION POSSIBILITIES:
IMPROVED MOLD SURFACES, MECHANICAL POLISHING,
ION-BEAM FIGURING, EXCIMER LASER MACHINING,
VAPOR DEPOSITION SMOOTHING; CORRECTIONS AT
THE SECONDARY REFLECTOR**
- **LARGE COMPOSITE REFLECTORS MAY EVENTUALLY (?)
OPERATE IN THE VISIBLE REGIONS**